Sear	ch Noi	es

Application/Control No.	Applicant(s)/Patent under Reexamination
09/291,832	JACOBSEN ET AL.
Examiner	Art Unit
Jean E. Lesperance	2674

	SEARCHED		
Class	Subclass	Date	Examiner
345	173	8/18/2005	JL
345	174	8/18/2005	JL
345	175	8/18/2005	JL
345	177	8/18/2005	JĹ
345	207	8/18/2005	JL
345	102	8/18/2005	JL
349	12	8/18/2005	JL
349	62	8/18/2005	JL
349	63	8/22/2005	JL
349	65	8/22/2005	JL
178	18.01	8/22/2005	JL.
178	18.1	8/22/2005	JL

INTERFERENCE SEARCHED			
Subclass	Date	Examiner	
search	8/22/2005	JL	
	Subclass	Subclass Date search 8/22/2005	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
East Search and copy attached Interference search. Inventor search Consulted with Henry Tran (primary examiner 2674)	8/22/2005	JL
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